


<b>Search Notes</b>  	<b>Application/Control No.</b>  10625389	<b>Applicant(s)/Patent Under Reexamination</b>  IDNANI, AJAYKUMAR R.
	<b>Examiner</b>  PHILIP C LEE	<b>Art Unit</b>  2152

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE: Bunjob Jaroenchonwanit regarding allowable subject matter	3/21/07	/pl/
Keywords Search in 455/456, 435; 709/200,230,231,202,245; 370/338,349 in EAST	2/13/08	/pl/
Search in 455/456, 435; 709/200,230,231,202,245; 370/338,349 in PG Pub	2/13/08	/pl/
Google Search	2/13/08	/pl/
ACM/IEEE Search	2/13/08	/pl/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
455	456,435	2/13/08	/pl/
370	338,349	2/13/08	/pl/
709	200,202,230,231,245	2/13/08	/pl/